DUAL 4-LINE TO 1-LINE DATA SELECTORS/MULTIPLEXERS WITH 3-STATE OUTPUTS

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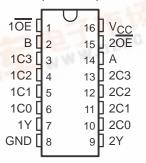
- 3-State Version of 'HC153
- High-Current Inverting Outputs Drive up to 15 LSTTL Loads
- Permit Multiplexing from n Lines to One Line
- Perform Parallel-to-Serial Conversion
- Package Options Include Plastic Small-Outline (D) and Ceramic Flat (W)
 Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J)
 300-mil DIPs

description

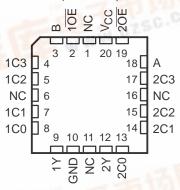
Each of these data selectors/multiplexers contain inverters and drivers to supply full binary decoding data selection to the AND-OR gates. Separate output-control inputs are provided for each of the two 4-line sections.

The 3-state outputs can interface with and drive data lines of bus-organized systems. With all but one of the common outputs disabled (at the high-impedance state), the low impedance of the single enabled output drives the bus line to a high or low logic level. Each output has its own output-enable (\overline{OE}) input. The outputs are disabled when their respective \overline{OE} is high.

SN54HC253...J OR W PACKAGE SN74HC253...D OR N PACKAGE (TOP VIEW)



SN54HC253 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

The SN54HC253 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74HC253 is characterized for operation from –40°C to 85°C.

FUNCTION TABLE

37	INPUTS									
SELI	ЕСТ†		D	ATA		OUTPUT				
В	Α	C0	C1	C2	C3	ŌĒ	'			
Х	Х	Х	Х	Х	Χ	Н	Z			
L	L	L	Χ	X	Χ	L	L			
L	L	Н	Χ	X	Χ	L	Н			
L	Н	Х	L	X	Χ	L	L			
L	Н	Х	Н	X	X	L	H			
Н	L	Χ	Х	L	X	L	L			
Н	- E	Х	X	Н	X	L	Н			
Н	H	Х	X	X	L	L	L			
Had	Н	X	Χ	X	Н	L	н			

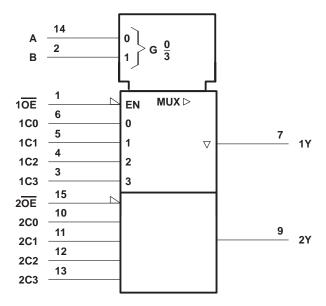
[†] Select inputs A and B are common to both sections.

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logic symbol†

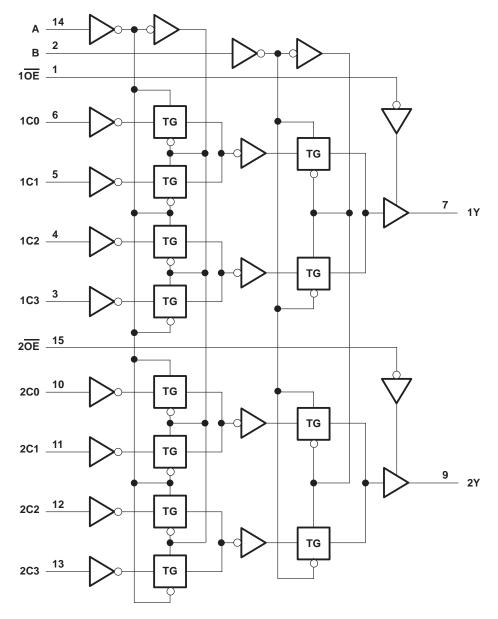


 $[\]dagger$ This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, J, N, and W packages.



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logic diagram (positive logic)



Pin numbers shown are for the D, J, N, and W packages.

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absolute maximum ratings over operating free-air temperature range†

Supply voltage range, V _{CC}	–0.5 V to 7 V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$) (see Note 1)	±20 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC}) (see Note 1)	$\dots \dots \pm 20 \text{ mA}$
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±25 mA
Continuous current through V _{CC} or GND	±50 mA
Package thermal impedance, θ _{JA} (see Note 2): D package	113°C/W
N package	78°C/W
Storage temperature range, T _{ctg}	65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.

recommended operating conditions

			SI	SN54HC253		SN74HC253			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage		2	5	6	2	5	6	V
		V _{CC} = 2 V	1.5			1.5			
V_{IH}	High-level input voltage	V _{CC} = 4.5 V	3.15			3.15			V
		VCC = 6 V	4.2			4.2			
	Low-level input voltage	V _{CC} = 2 V	0		0.5	0		0.5	
V_{IL}		V _{CC} = 4.5 V	0		1.35	0		1.35	V
		V _{CC} = 6 V	0		1.8	0		1.8	
٧ _I	Input voltage		0		VCC	0		VCC	V
VO	Output voltage		0		VCC	0		VCC	V
		V _{CC} = 2 V	0		1000	0		1000	
t _t	Input transition (rise and fall) time	V _{CC} = 4.5 V	0		500	0		500	ns
		V _{CC} = 6 V	0		400	0		400	
TA	Operating free-air temperature	-	-55		125	-40		85	°C



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		Vaa	Т	A = 25°C	;	SN54HC253		SN74HC253		UNIT
PARAMETER	lEST CC	VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT	
			2 V	1.9	1.998		1.9		1.9		
		I _{OH} = -20 μA	4.5 V	4.4	4.499		4.4		4.4		
VOH	$V_I = V_{IH}$ or V_{IL}		6 V	5.9	5.999		5.9		5.9		٧
		$I_{OH} = -6 \text{ mA}$	4.5 V	3.98	4.3		3.7		3.84		
		$I_{OH} = -7.8 \text{ mA}$	6 V	5.48	5.8		5.2		5.34		
	VI = VIH or VIL	I _{OL} = 20 μA	2 V		0.002	0.1		0.1		0.1	
			4.5 V		0.001	0.1		0.1		0.1	
VOL			6 V		0.001	0.1		0.1		0.1	V
		I _{OL} = 6 mA	4.5 V		0.17	0.26		0.4		0.33	
		$I_{OL} = 7.8 \text{ mA}$	6 V		0.15	0.26		0.4		0.33	
lį	$V_I = V_{CC}$ or 0		6 V		±0.1	±100		±1000		±1000	nA
loz	$V_O = V_{CC}$ or 0				±0.01	±0.5		±10		±5	μΑ
Icc	$V_I = V_{CC}$ or 0,	IO = 0	6 V			8		160		80	μΑ
C _i		·	2 V to 6 V		3	10		10		10	pF

switching characteristics over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	Vaa	T,	չ = 25°C	;	SN54H	C253	SN74H	C253	UNIT	
PARAMETER	(INPUT)	(OUTPUT)	VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII	
			2 V		62	150		225		190		
	A or B	Any Y	4.5 V		19	30		45		38		
			6 V		16	26		38		32		
^t pd			2 V		54	126		210		175	ns	
	Data (Any C)	Y	4.5 V		16	28		42		35		
			6 V		13	23		36		30		
		Y	2 V		28	100		150		125	ns	
t _{en}	ŌĒ		4.5 V		11	20		30		25		
			6 V		9	17		26		21		
			2 V		21	135		203		170	0	
^t dis	ŌĒ	Y	4.5 V		14	30		45		38	ns	
			6 V		12	35		38		31		
			2 V		28	60		90		75		
t _t		Υ	Υ	4.5 V		8	12		18		15	ns
			6 V		6	10		15		13		

SN54HC253, SN74HC253 **DUAL 4-LINE TO 1-LINE DATA SELECTORS/MULTIPLEXERS** WITH 3-STATE OUTPUTS SCL\$133B - DECEMBER 1982 - REVISED MAY 1997

switching characteristics over recommended operating free-air temperature range, C_L = 150 pF (unless otherwise noted) (see Figure 1)

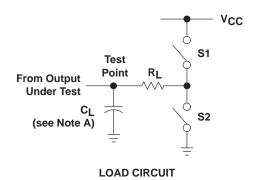
PARAMETER	FROM	то	V	T	\ = 25°C	;	SN54H	IC253	SN74H	IC253	UNIT			
PARAMETER	(INPUT)	(OUTPUT)	VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT			
			2 V		76	235		355		295				
	A or B	Any Y	4.5 V		23	47		71		59				
. .			6 V		20	41		60		51	ns			
^t pd	Data (Any C)	Y	2 V		68	220		335		275				
			4.5 V		20	44		67		55				
			6 V		17	38		57		51				
	ŌĒ	Y	2 V		44	185		280		230				
t _{en}			Υ	4.5 V		16	37		56		46	ns		
			6 V		14	32		48		40				
			2 V		45	210		315		265				
t _t		Υ	Υ	Υ	Υ	4.5 V		17	42		63		53	ns
			6 V		13	36		53		45				

operating characteristics, $T_A = 25^{\circ}C$

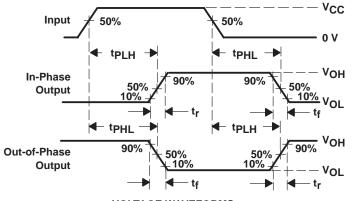
	PARAMETER	TEST CONDITIONS	TYP	UNIT
C _{pd}	Power dissipation capacitance per multiplexer	No load	45	pF

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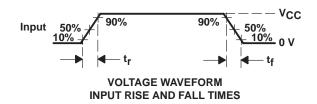
PARAMETER MEASUREMENT INFORMATION

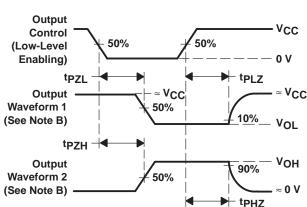


PARAI	METER	R _L C _L		S1	S2	
	tPZH	1 k Ω	50 pF or	Open	Closed	
t _{en}	tPZL	1 K22	150 pF	Closed	Open	
4	tPHZ	1 kΩ	50 pF	Open	Closed	
^t dis	tPLZ	1 K22	30 pr	Closed	Open	
t _{pd} or	t _t	_	50 pF or 150 pF	Open	Open	



VOLTAGE WAVEFORMS
PROPAGATION DELAY AND OUTPUT TRANSITION TIMES





VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES FOR 3-STATE OUTPUTS

NOTES: A. C_L includes probe and test-fixture capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \ \Omega$, $t_r = 6 \ ns$, $t_f = 6 \ ns$.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



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